

# **Advanced Interconnect Development**

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Prabhakar Singh, Jeff Stevenson, Gordon Xia**

**6<sup>th</sup> SECA Annual Workshop**

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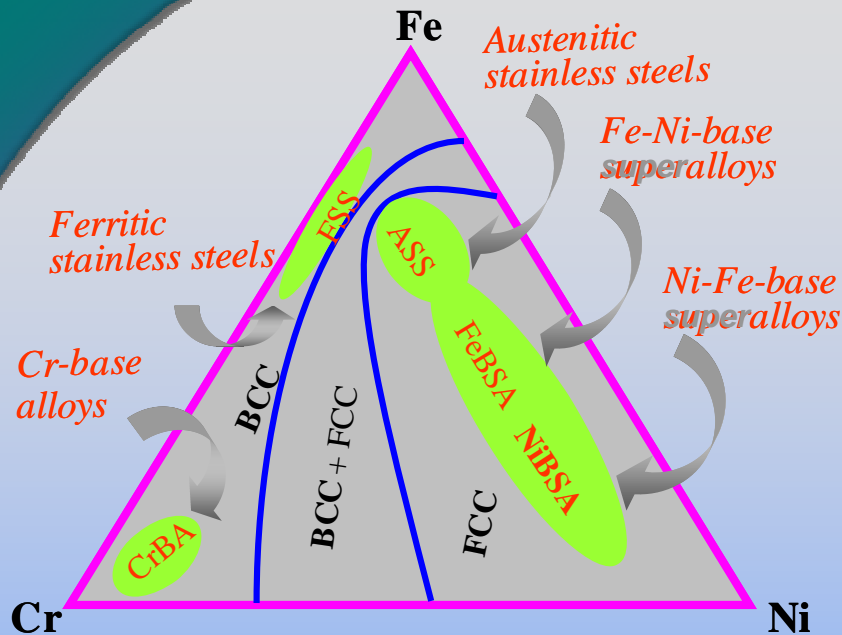
# Objectives

- Develop cost-effective, optimized materials for intermediate temperature SOFC interconnects and interconnect/electrode interface applications.
- Identify and understand degradation processes in interconnects and at their interfaces with electrodes and seals.

# Approach

## Oxidation resistant alloys:

- { Alumina-forming alloys
- { Chromia-forming alloys
- { Body-centered-cubic (BCC)  
e.g. ferritic steels
- { Face-centered-cubic (FCC)  
e.g. austenitic Fe-Cr, Ni-Cr-base alloys



Yang, Weil, Paxton, Stevenson, J. Electrochem. Soc., 150 (2003) A1188.

- Screening-studies of conventional and newly developed alloys
- Investigation and understanding of degradation in metallic interconnects and at their interfaces under SOFC operating conditions.
- Materials development
  - ✚ Surface modification
  - ✚ Bulk alloy development
  - ✚ Electrode/interconnect interfaces

# Focus Areas & Accomplishments



## Ferritic stainless steel interconnects with spinel protection layer

- ❖ Thermally grown  $(\text{Mn,Co})_3\text{O}_4$  spinel protection layers on FSS;
- ❖ Characterized thermally, electrically, and electrochemically.



## Austenitic-base alloys and laminated, composite interconnect structures

- ❖ Developed Ni-base alloys for improved scale properties.
- ❖ Investigated the feasibility of cladding approach for fabrication of laminated, composite metallic interconnects.



## Interactions and contact layer b/w cathode and interconnect

- ❖ Screening-studied perovskites as an electrical contact layer and interactions b/w metallic interconnects and the perovskites;
- ❖ Developed new electrical contacts and methods of making them.



## Degradation of metallic interconnects under SOFC operating conditions

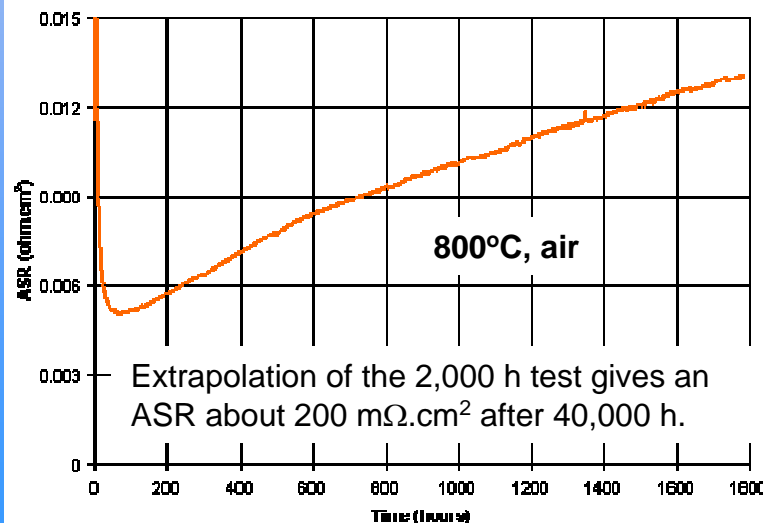
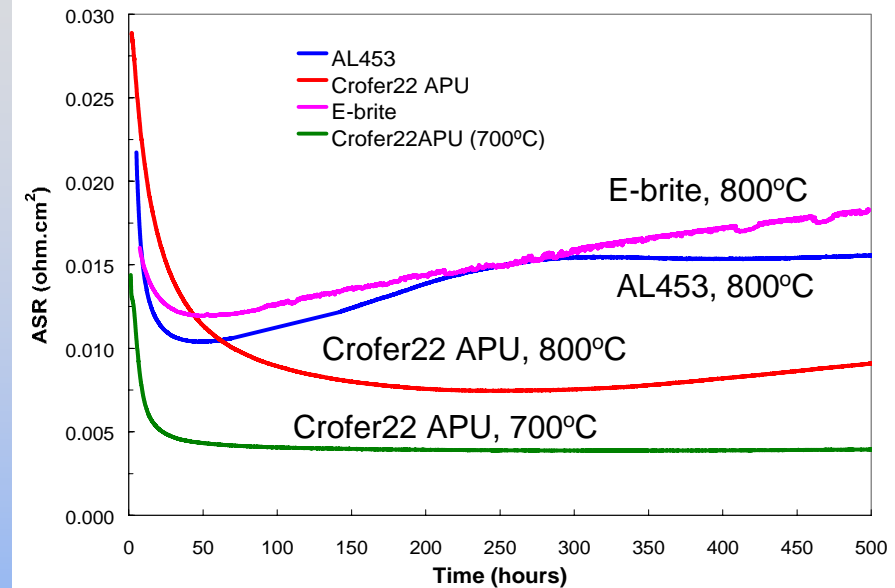
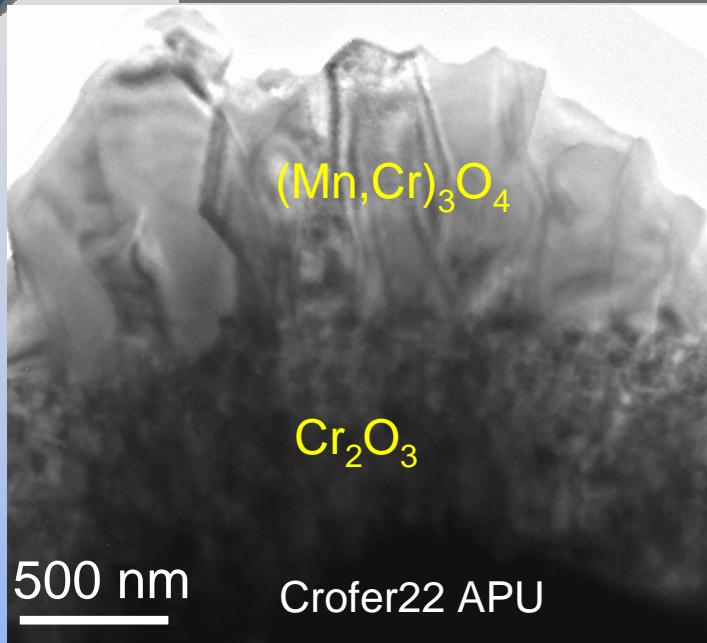
- ❖ Investigated oxidation behavior of metals and oxidation resistant alloys under dual exposures;
- ❖ Carried out advanced analyses to gain fundamental understanding.

# Focus Areas

- Ferritic stainless steel interconnect with spinel protection layer
- Austenitic-base alloys, and laminated, composite interconnect structures
- Interactions and contact layer b/w cathode and interconnect
- Degradation of metallic interconnects under SOFC operating conditions

# Protection Layer: The Need

✚ To improve long term scale structural and electrical stability.



After 6 months, 100 cycles, 800°C

Crofer22 APU

20kV X1,000 10μm 04s915f

Yang, Hardy, Walker, Xia, Simner, Stevenson, J. Electrochem. Soc., 151 (2004) A1582.

Yang, Stevenson, Meinhardt, Solid State Ionics, 160, 213 (2003).

# Protection Layer: The Need

✚ To mitigate or prevent Cr migration and potential poisoning.

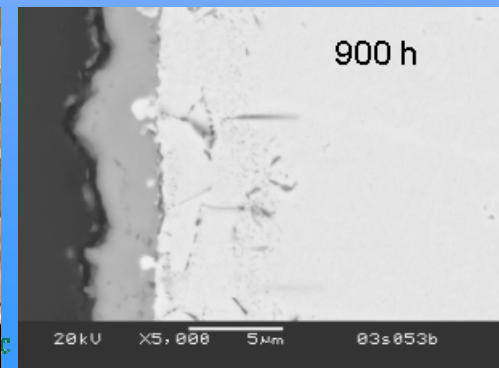
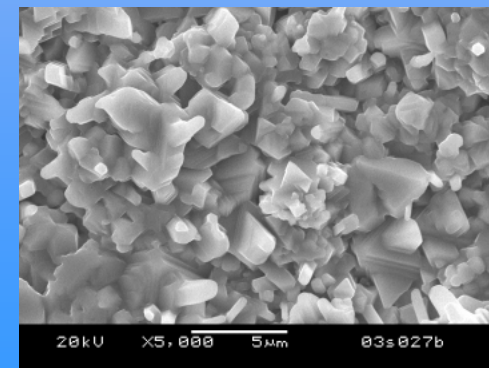
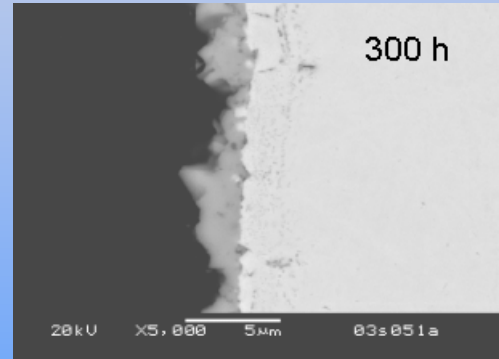
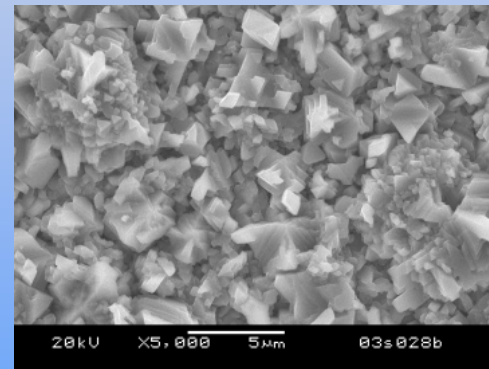
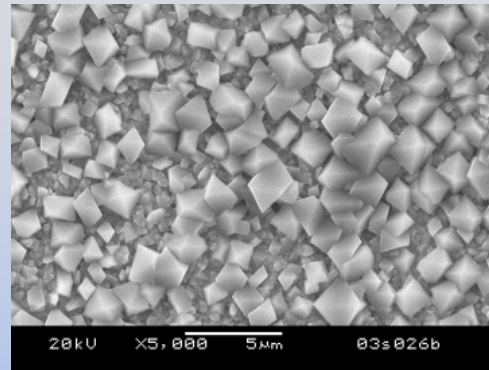
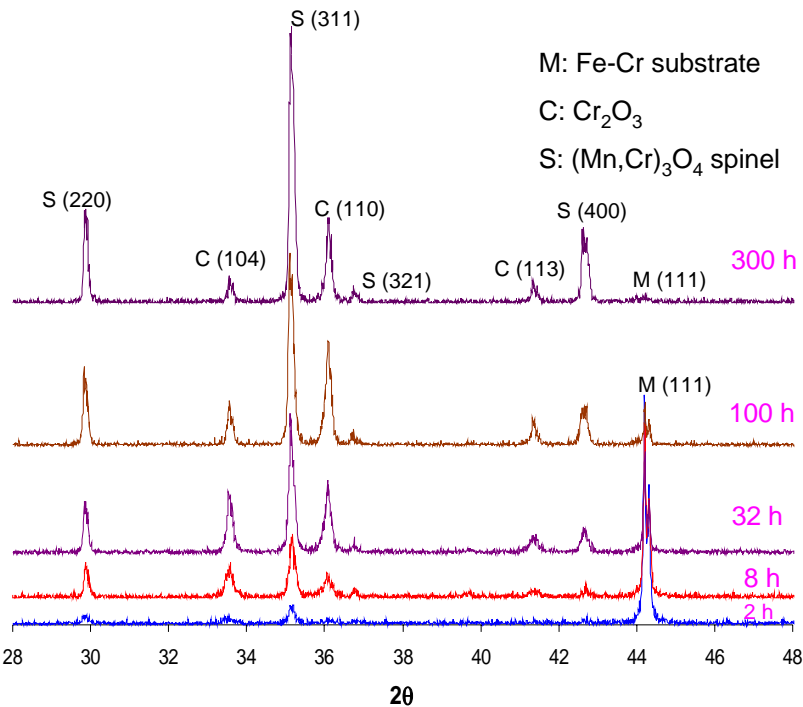
Crofer22 APU, 800°C, in air

## In-situ X-Ray Diffraction Analysis

M: Fe-Cr substrate

C:  $\text{Cr}_2\text{O}_3$

S:  $(\text{Mn,Cr})_3\text{O}_4$  spinel



Simner, Anderson, Xia, Yang, Pederson, Stevenson, J. Electrochem. Soc., 152 (2005) A740.

Yang, Meinhardt, Stevenson, J. Electrochem. Soc., 150, A1095 (2003).

Battelle

U.S. Department of Energy



# Development of $(\text{Mn,Co})_3\text{O}_4$ Spinel Protection Layer

## Why $(\text{Mn,Co})_3\text{O}_4$ spinel?

- Electrical conductivity:

$$\sigma_{(\text{Mn,Co})_3\text{O}_4} = 10^{3\sim4} \sigma_{\text{Cr}_2\text{O}_3} = 10^{2\sim3} \sigma_{\text{MnCr}_2\text{O}_4}$$

- Appropriate CTE:

$$\text{CTE}_{\text{Mn}_{1.5}\text{Co}_{1.5}\text{O}_4} = 11.5 \times 10^{-6} \text{ K}^{-1}, 20 - 800^\circ \text{C}$$

- Non-Cr containing: Cr-containing oxides will release Cr
- Flexibility of fabrication: THERMAL GROWTH

## Why thermal growth?

- Strong adherence to the substrate;
- Introduction of porosity for strain tolerance;
- Improved thermomechanical stability;
- Cost effectiveness.

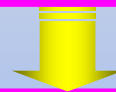
Larring, Norby, J. Electrochem., Soc., 147, 3251 (2000).

Yang, Xia, Singh, Stevenson, SECA Annual Workshop, Boston, May 11-13, 2004.

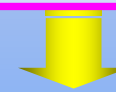
Yang, Xia, Stevenson, Electrochem. & Solid State Lett., 8 (2005) A168.

## Approach

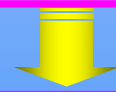
Preparation of  
 $(\text{Mn,Co})_3\text{O}_4$ :  
SS or GNP



Solution based  
coating



Heat-treated in reducing  
environments



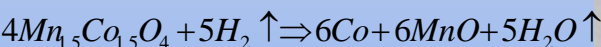
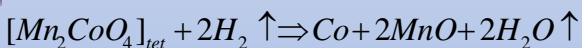
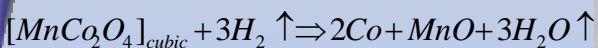
Thermally grown during  
heating in oxidizing  
environments or during  
first SOFC stack heating



# Thermal Growth of $\text{Mn}_{1.5}\text{Co}_{1.5}\text{O}_4$ on FSSs

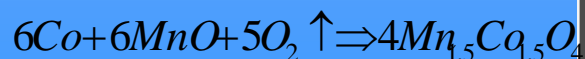
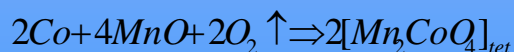
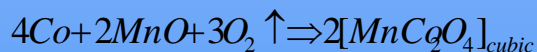
## Reduction

In  $\text{H}_2/\text{Ar}+3\% \text{H}_2\text{O}$ , 800°C, 24h

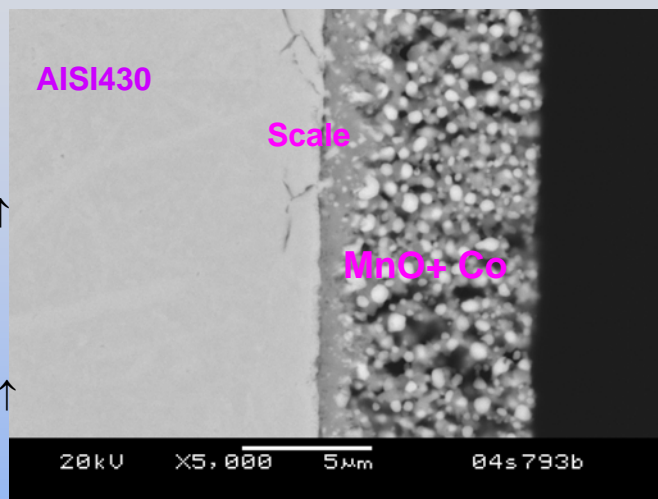


## Oxidation

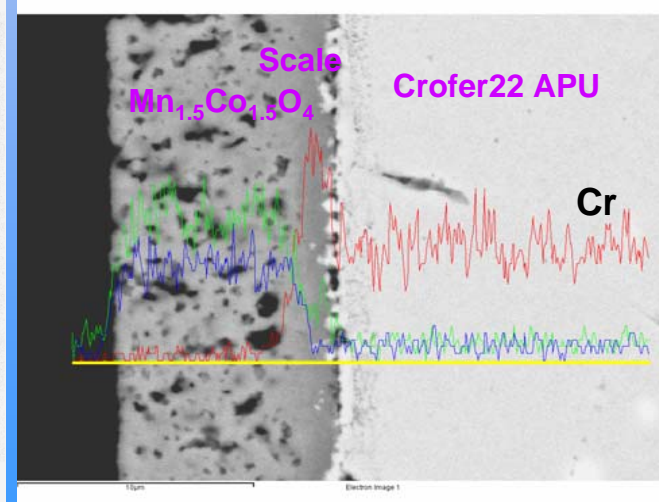
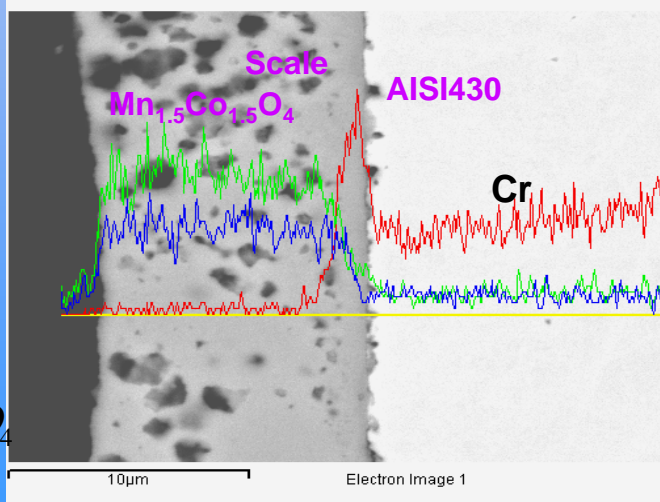
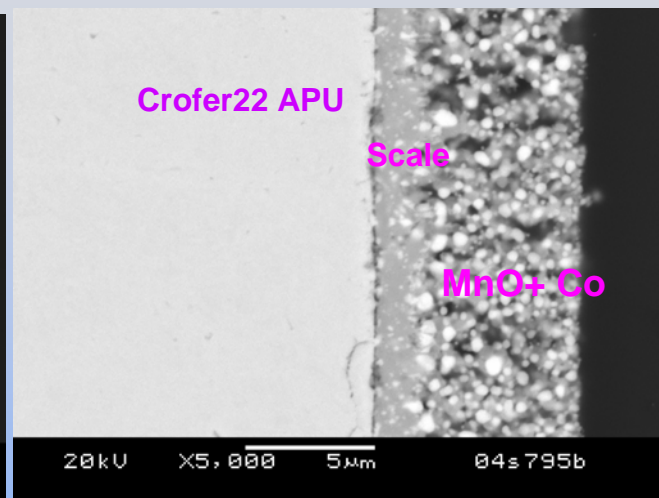
Air+3%  $\text{H}_2\text{O}$ , 800°C, 100h



AISI430

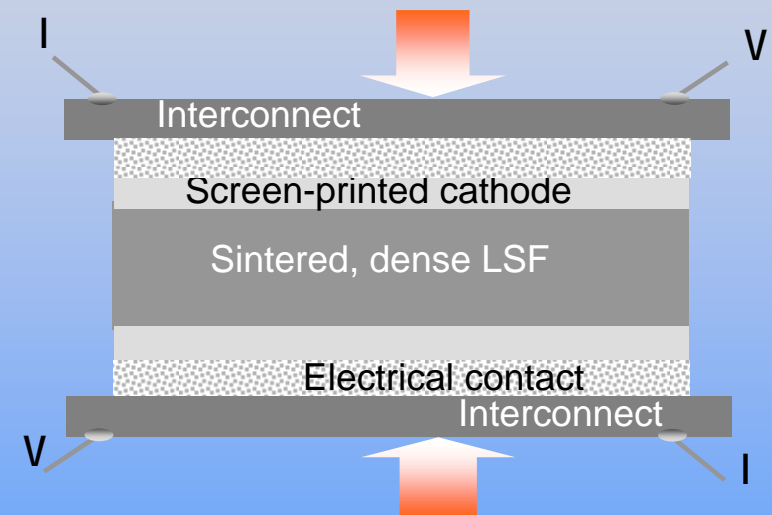
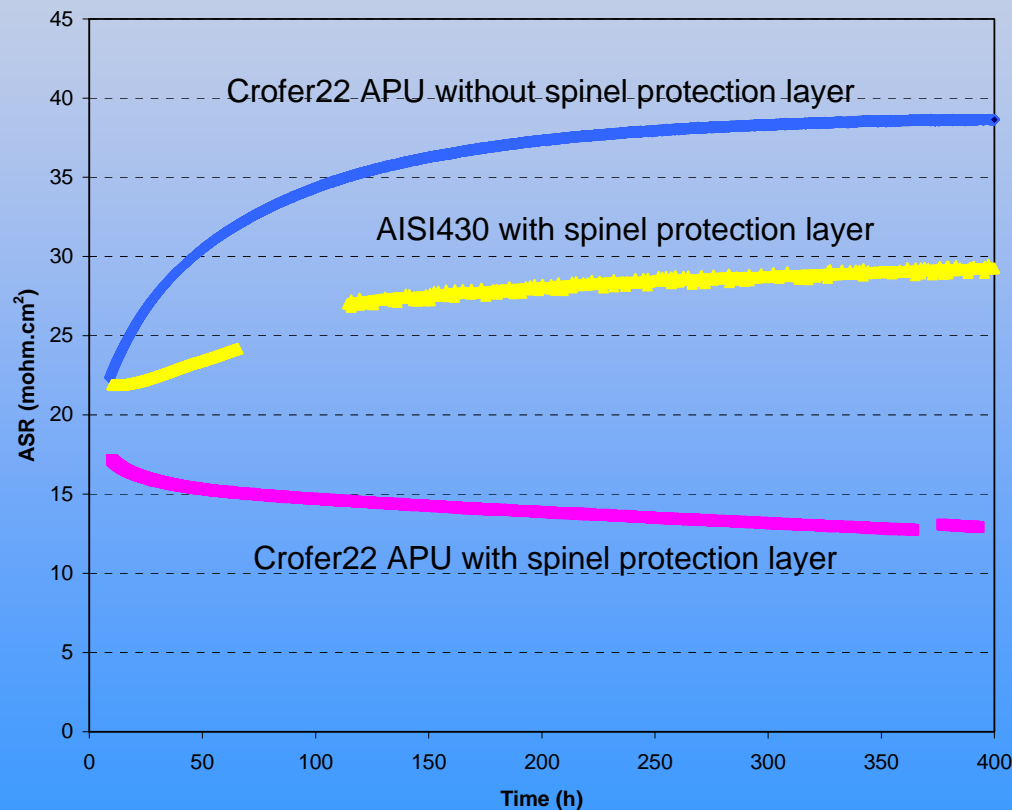


Crofer22APU



# Contact ASR w & w/o Protection Layers

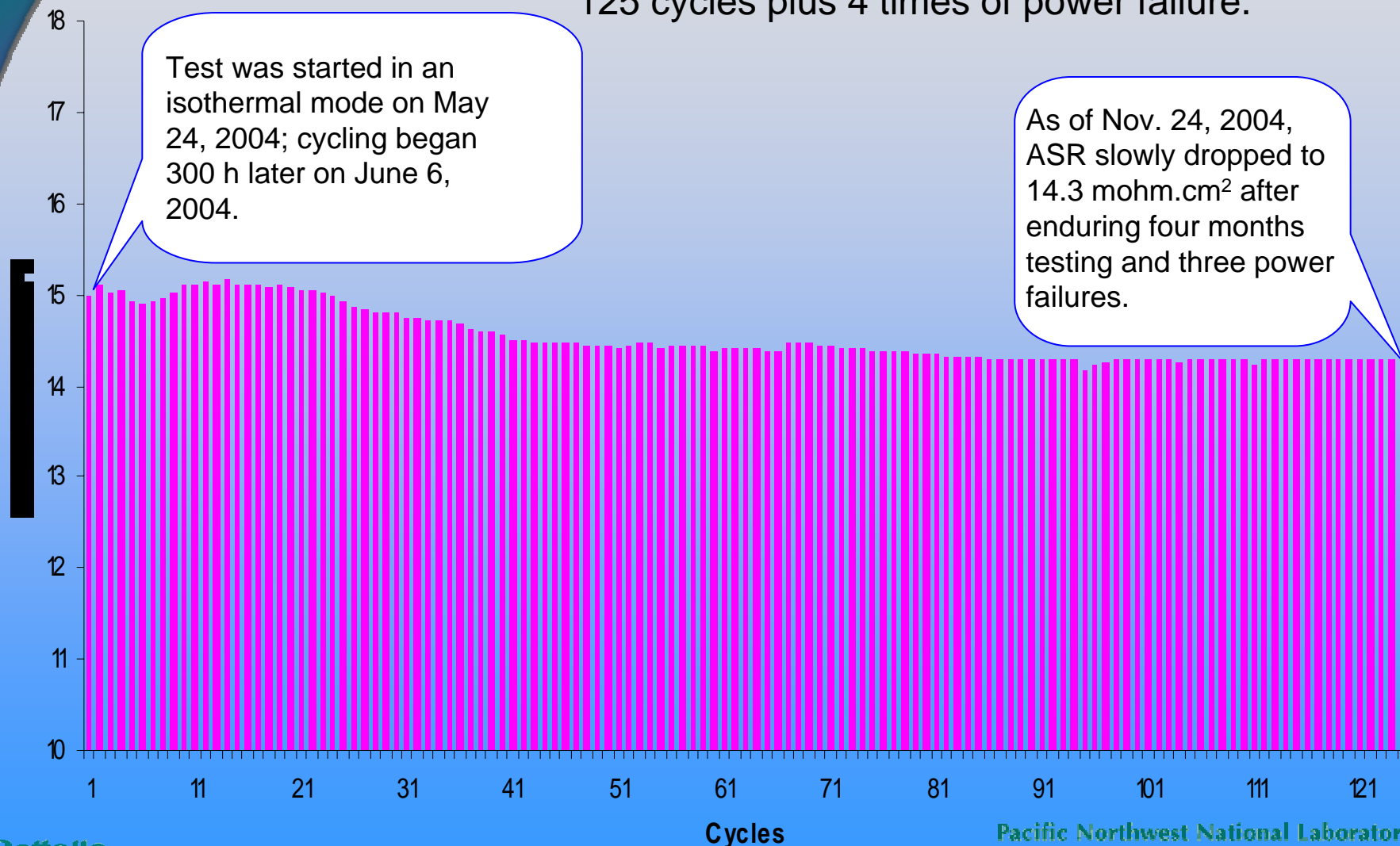
$$ASR_{cathode/interconnect} = \Phi(scale, contacts, reactions)$$



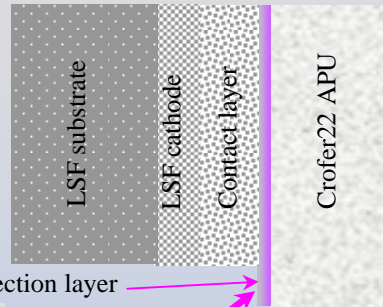
LSCM electrical contact, 800°C, air

# Six Month Thermal Cycling Test

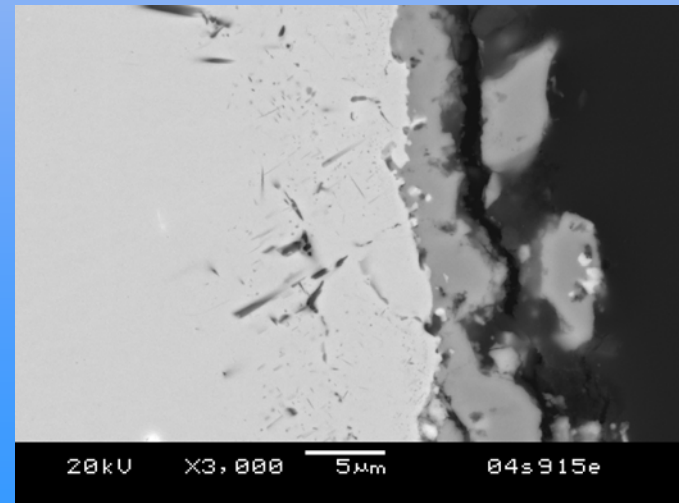
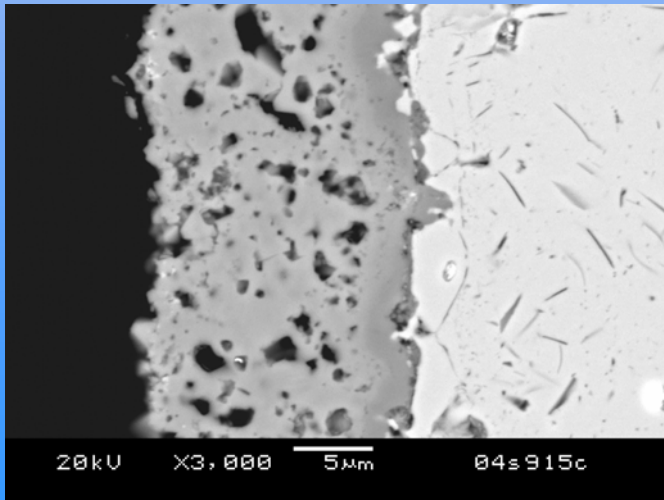
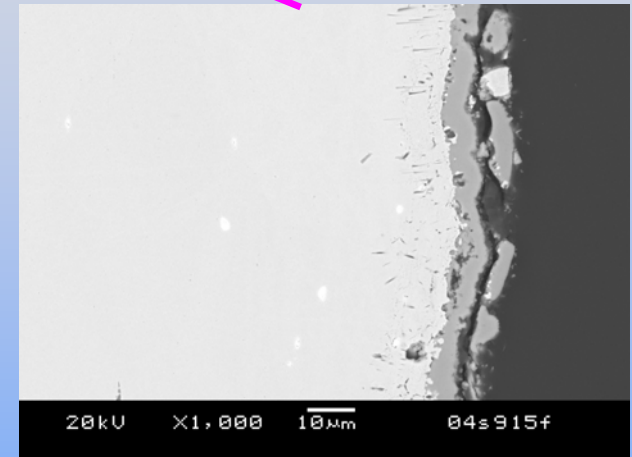
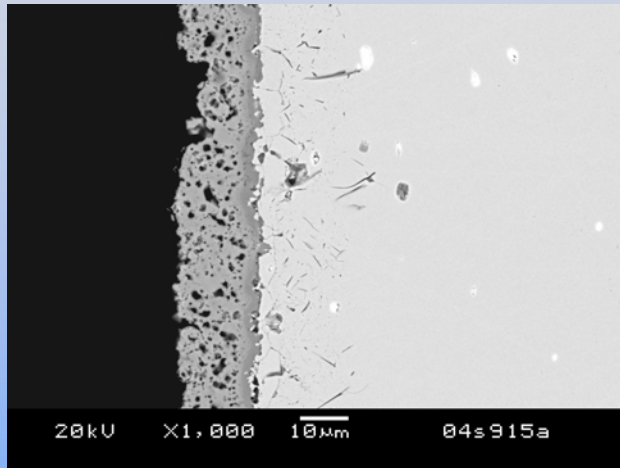
IRU test: 800°C, air, cycling from 80-800°C,  
125 cycles plus 4 times of power failure.



# Improved Surface Stability

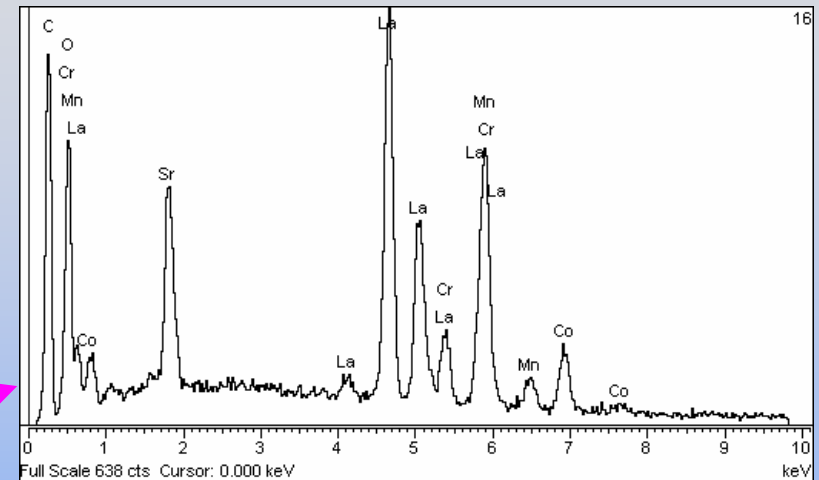
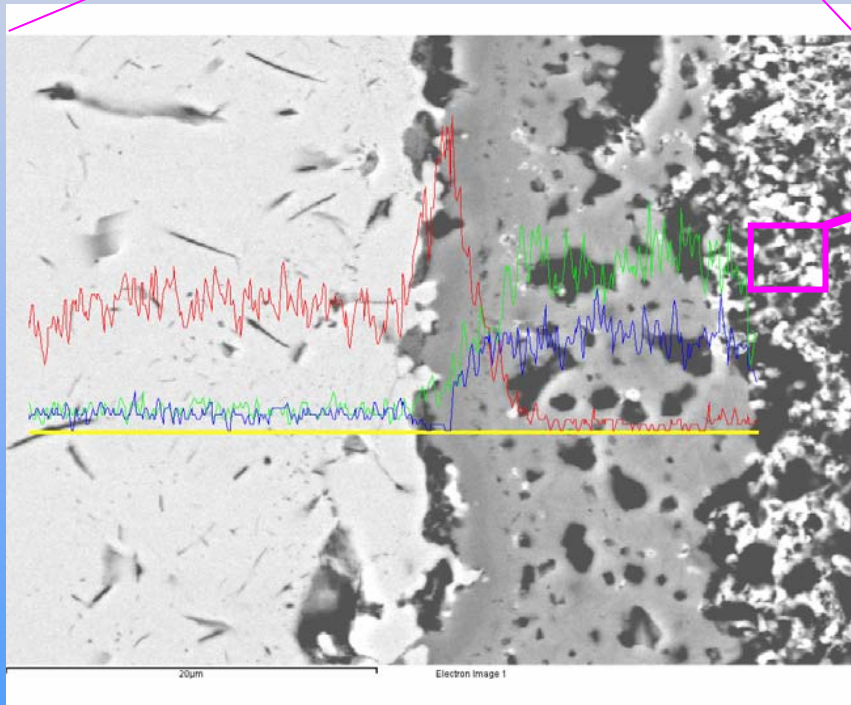
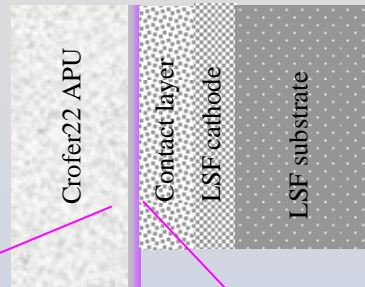


Protection layer



# Effective Cr-Barrier

No Cr migration across the spinel protection layer after six months of heating and cycling.



Element	App	Intensity	Weight%	Weight%	Atomic%
	Conc.	Corn.		Sigma	
O K	11.20	1.1185	16.01	0.63	51.91
Cr K	0.00	1.0284	0.00	0.00	0.00
Mn K	10.78	0.9163	18.79	0.46	17.74
Co K	3.77	0.9180	6.56	0.36	5.77
Sr L	4.64	0.6073	12.20	0.56	7.23
La L	29.51	1.0148	46.45	0.68	17.35

Yang, Xia, Stevenson, Electrochem. & Solid State Lett., 8 (2005) A168.

Yang, Xia, Simner, Stevenson, J. Electrochem. Soc., in press (2005).

Simner, Anderson, Xia, Yang, Stevenson, J. Electrochem. Soc., in press (2005).

# Summary

- $\text{Mn}_{1.5}\text{Co}_{1.5}\text{O}_4$  spinel protection layers can be thermally grown on ferritic stainless steel interconnects.
- The thermally grown  $\text{Mn}_{1.5}\text{Co}_{1.5}\text{O}_4$  spinel protection layer:
  - improved surface stability
  - minimized contact resistance
  - prevented Cr migration
- The spinel protection layer demonstrated excellent long-term stability.



# Focus Areas

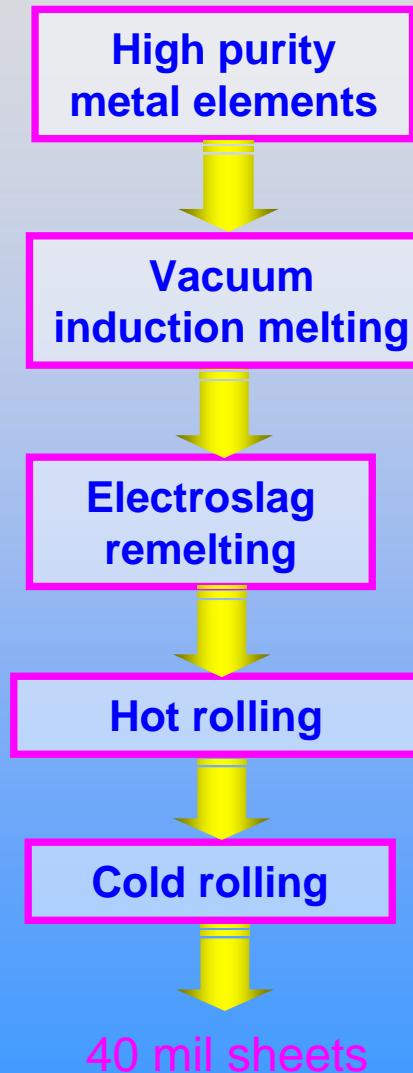
- Ferritic stainless steel interconnect with spinel protection layer
- Austenitic-base alloys, and laminated, composite interconnect structures
- Interactions and contact layer b/w cathode and interconnect
- Degradation of metallic interconnects under SOFC operating conditions



# Modification of Haynes 230

## Evaluation:

- Oxidation and scale growth in moist air as well as under dual environments
- Scale constitution and structure
- Scale electrical conductivity
- Thermal expansion

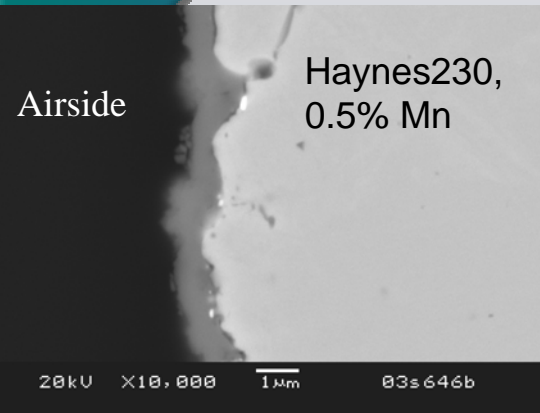


Heat No.	8305 7804	M1	M2
Chem. Comp.	0.5% Mn Haynes 230	1% Mn EN1304-4-812	2% Mn EN1404-4-813
Al	0.34	0.31	0.38
B	0.002	0.005	0.006
C	0.100	0.111	0.095
Co	<5.0	< 0.01	< 0.01
Cr	22.45	20.96	20.73
Cu	0.05	0.03	0.04
Fe	1.54	< 0.01	< 0.01
La	0.017	< 0.005	< 0.005
Mn	0.52	1.08	2.06
Mo	1.42	2.02	1.95
Ni	Bal	60.67	59.49
P	0.005	0.005	0.006
S	<0.002	0.003	0.002
Si	0.38	0.42	0.42
Ta	<0.100	0.06	0.06
Ti	<0.01	< 0.010	< 0.010
W	14.23	13.62	14.34

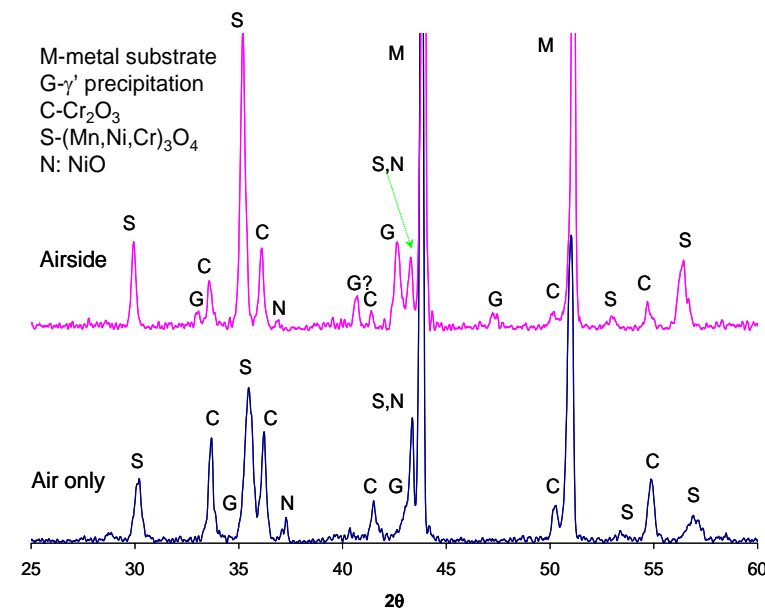
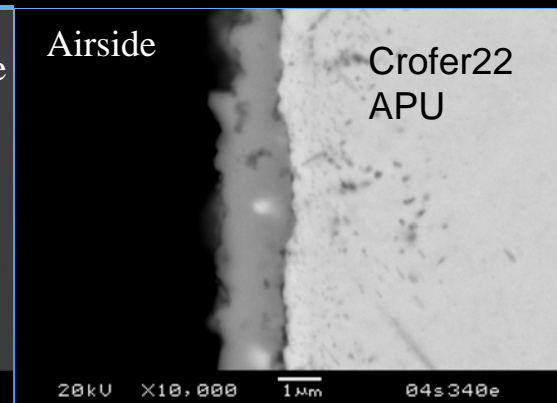
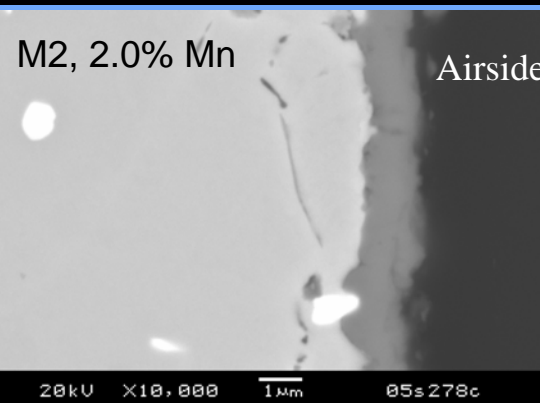
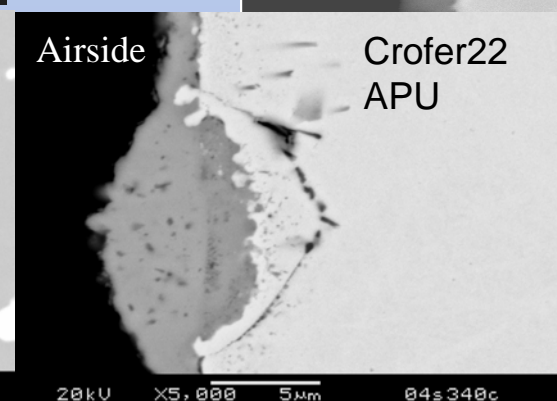
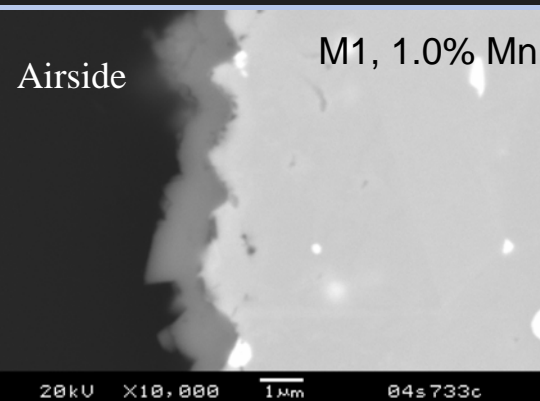
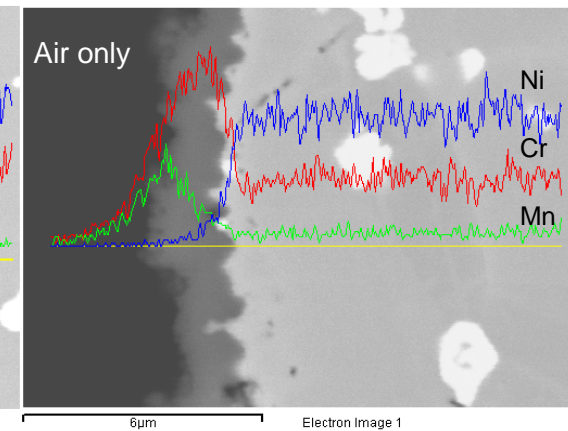
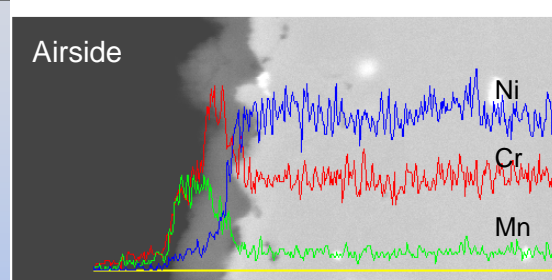
\* Alloys were made at Haynes International Inc.

# Scale Structure and Growth of M Alloys

- Scale structure similar to Crofer, i.e.  $(\text{Mn,Cr})_3\text{O}_4 + \text{Cr}_2\text{O}_3$ ;
- Mn addition increased scale growth, but still better than Crofer;
- Superior oxidation resistance under dual environments.

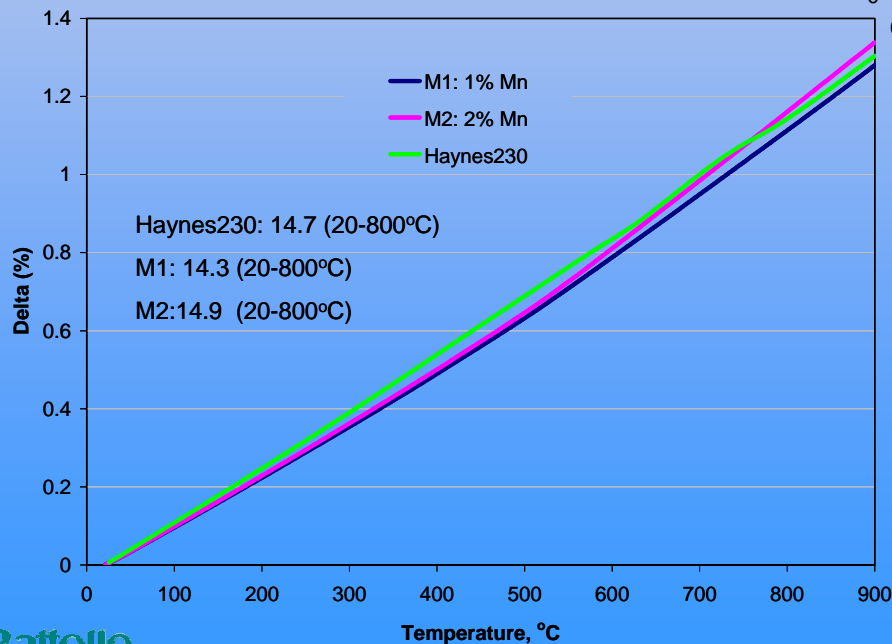
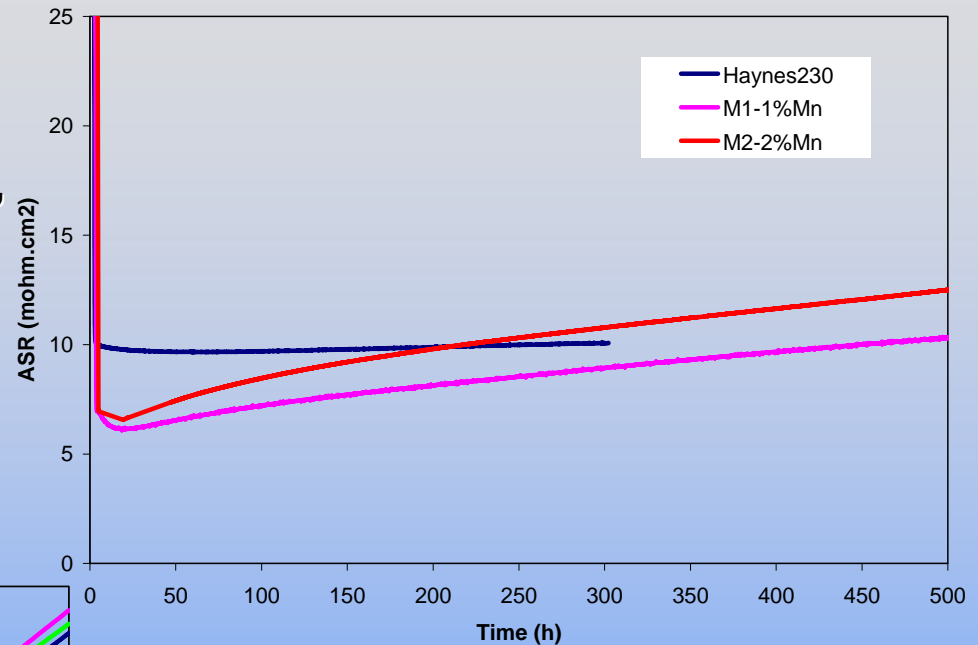


800°C,  
300h



# Properties of M Alloys

- $(\text{Mn,Cr})_3\text{O}_4$  spinel help improved scale conductivity,
- Mn addition increased scale growth rate and thus the scale electrical resistance.

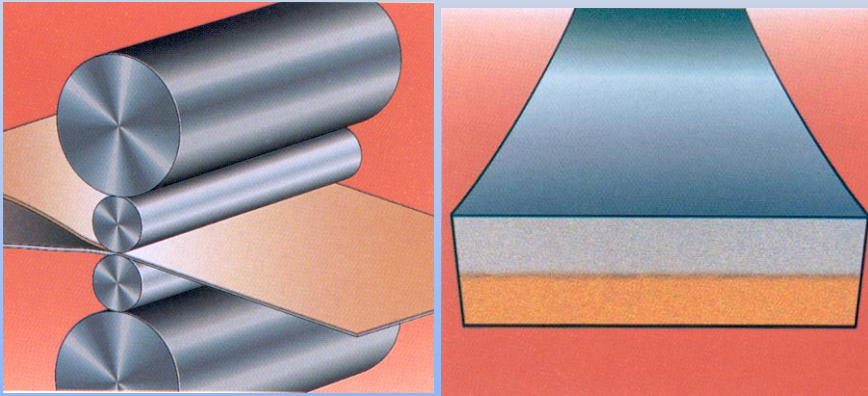


- CTE of M alloys is comparable to Haynes230 and higher than that of ceramic cells,
- Mn addition slightly increased CTE.

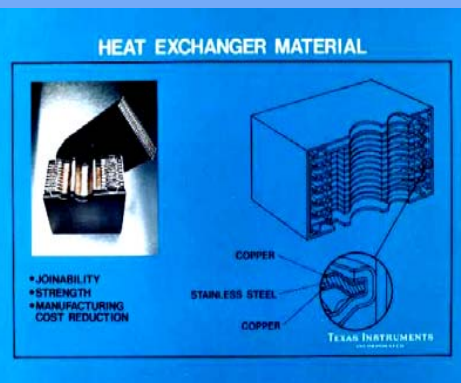
# Laminated, Composite Interconnect Structures via Cladding\*

## ► Clad Metal:

- A layered, composite metallic material



- Cost-effective and widely used in Industries as well as in our daily life

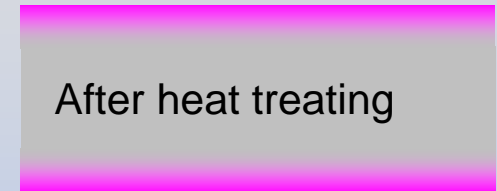
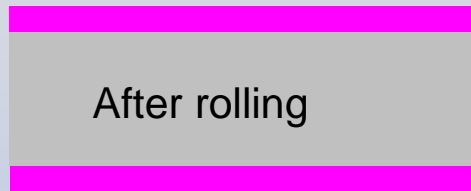
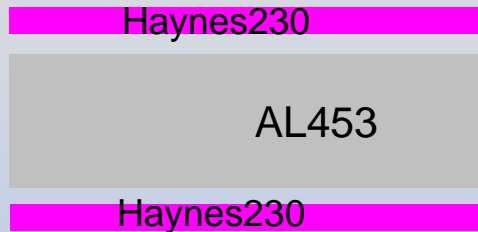


## ► Clad Metal for interconnect applications

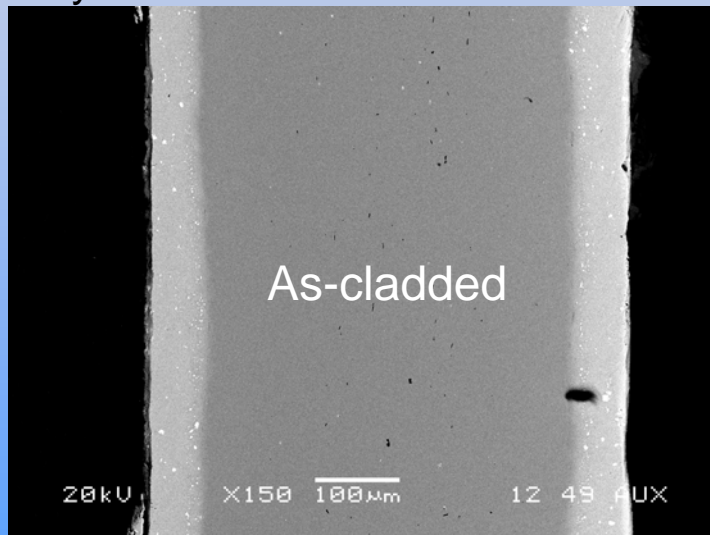
- Integrate advantages of different alloys, while avoiding disadvantages.
- ❖ Solve the issue of thermal expansion mismatch;
- ❖ Optimize the interconnect mechanical and structural stability;
- ❖ Make more cost-effective.
- Allow to address cathode- and anode-side issues separately;
- Mass production and very cost effective.

*\* Collaboration with Leigh Chen, Engineered Materials Solutions Inc.*

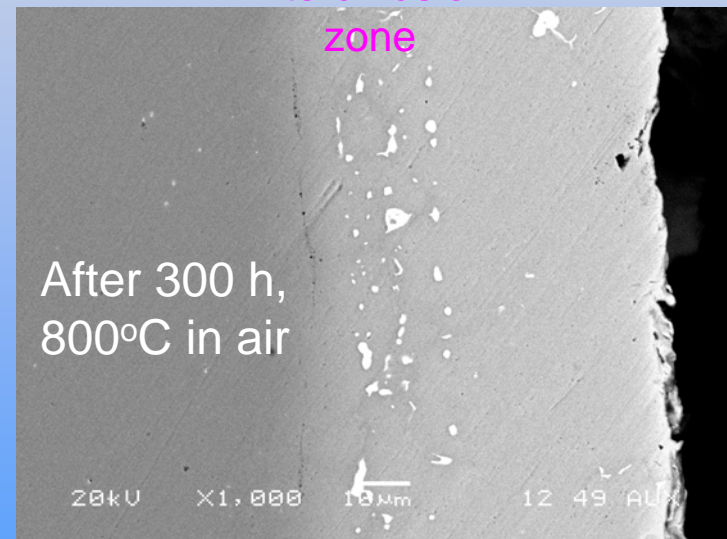
# Proof-of-Concept: Haynes230||AL453||Haynes230



Haynes230 AL453 Haynes230



AL453 Interdiffusion zone Haynes230



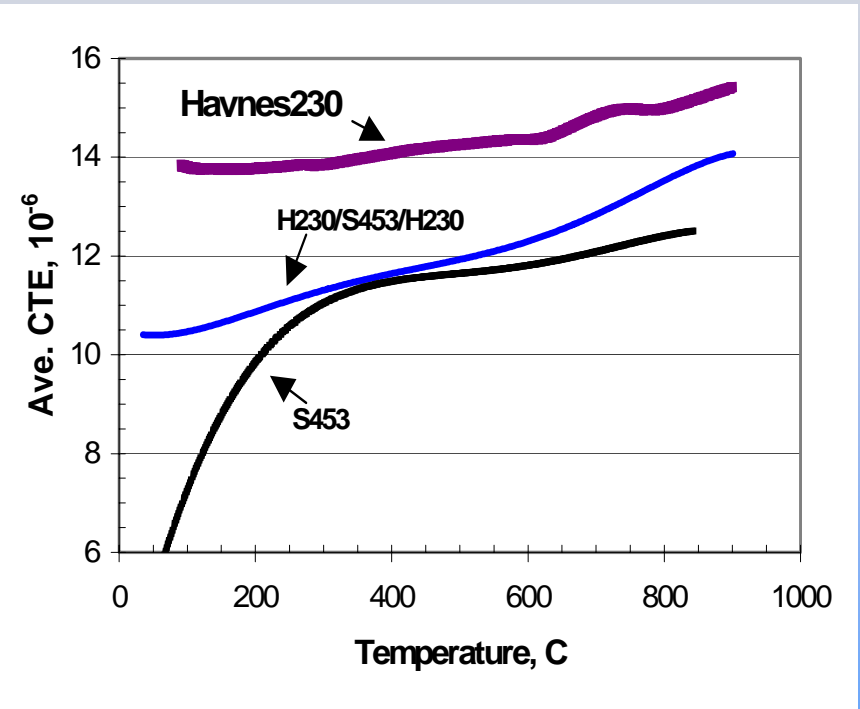
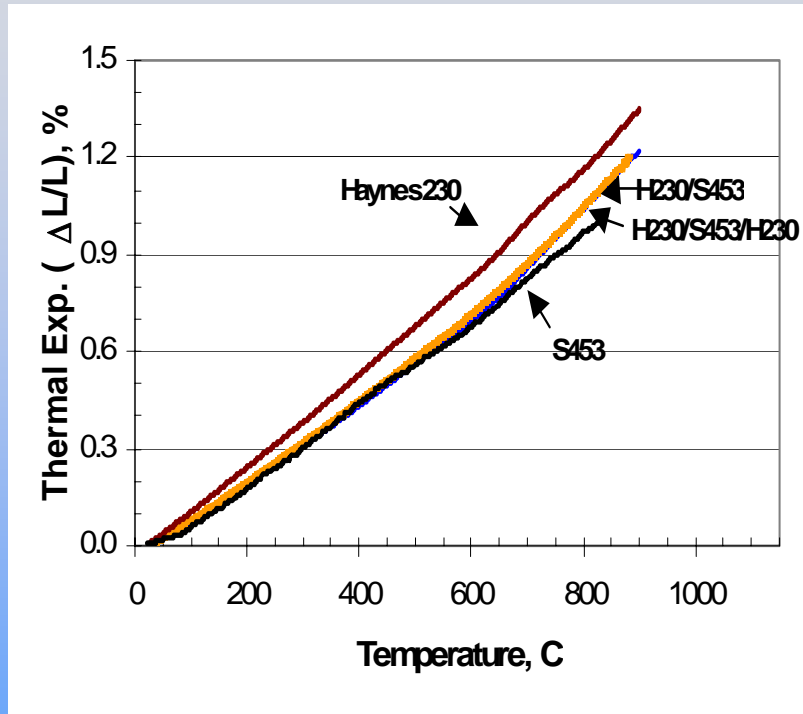
- The proof of concept work proved the viability of cladding FSS with Ni-based alloys and another piece of FSS;
- The cladded structures were stable during a subsequent heat treatment.



# Thermal Expansion of Clad Metals

Thermal expansion of clad metals, compared to Haynes 230 and Al453

CTE\* of the clad metal in comparison with that of Haynes230 and AL453



● The cladding is a viable approach to modify the thermal expansion of metallic interconnect and help improve its cost-effectiveness.

Chen, Yang, Jha, Xia, Stevenson, J. Power Sources, in press (2005).

# Summary

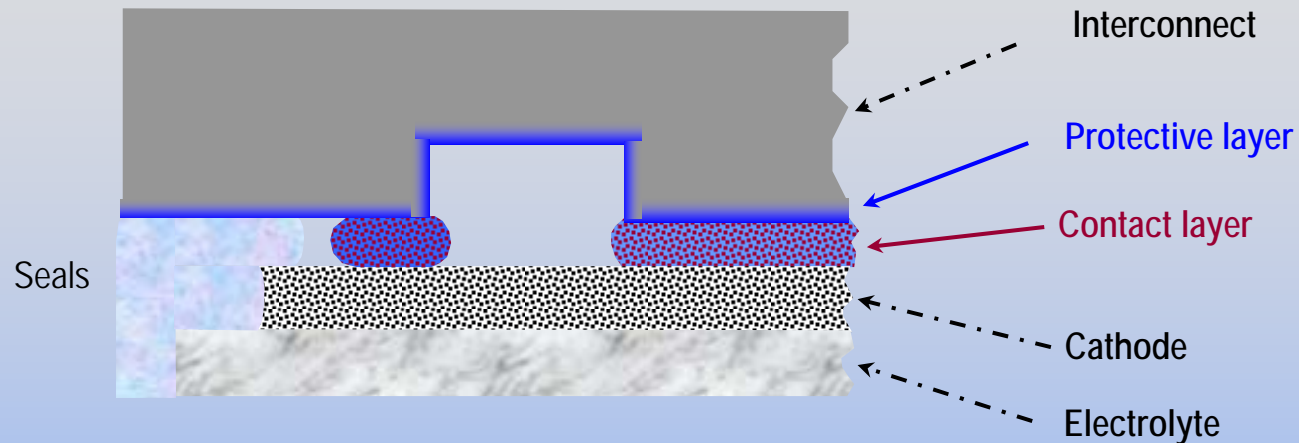
- The austenitic Ni-Cr-base alloys can be modified for improved properties for SOFC applications.
- The initial work demonstrated that cladding is a viable approach to fabricate laminated, composite interconnect structures that integrate the advantages of different alloys, while avoiding their disadvantages.



# Focus Areas

- Ferritic stainless steel interconnect with spinel protection layer
- Austenitic-base alloys, and laminated, composite interconnect structures
- Interactions and contact layer b/w cathode and interconnect
- Degradation of metallic interconnects under SOFC operating conditions

# Contact Layers



## Functions

- Promote electrical contact
- Facilitate stack assembling
- Act as a buffer zone to trap Cr

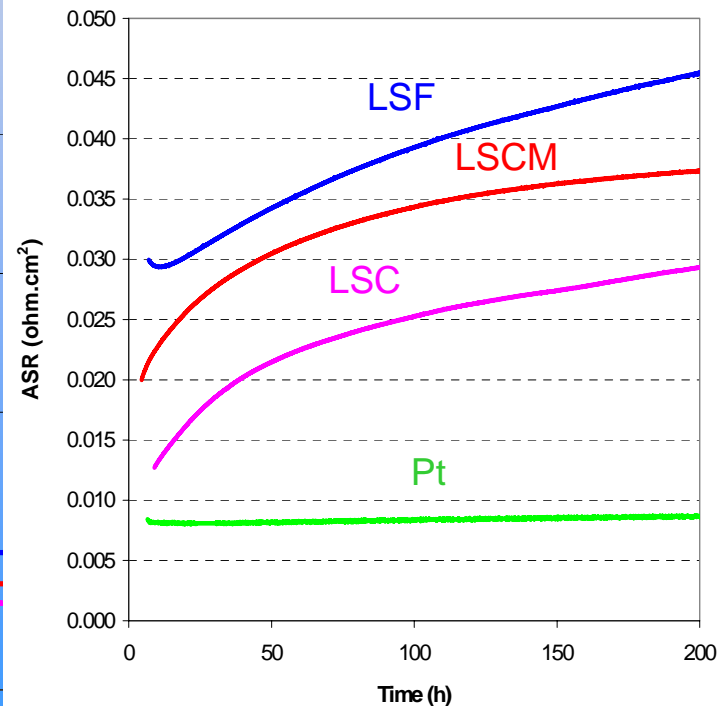
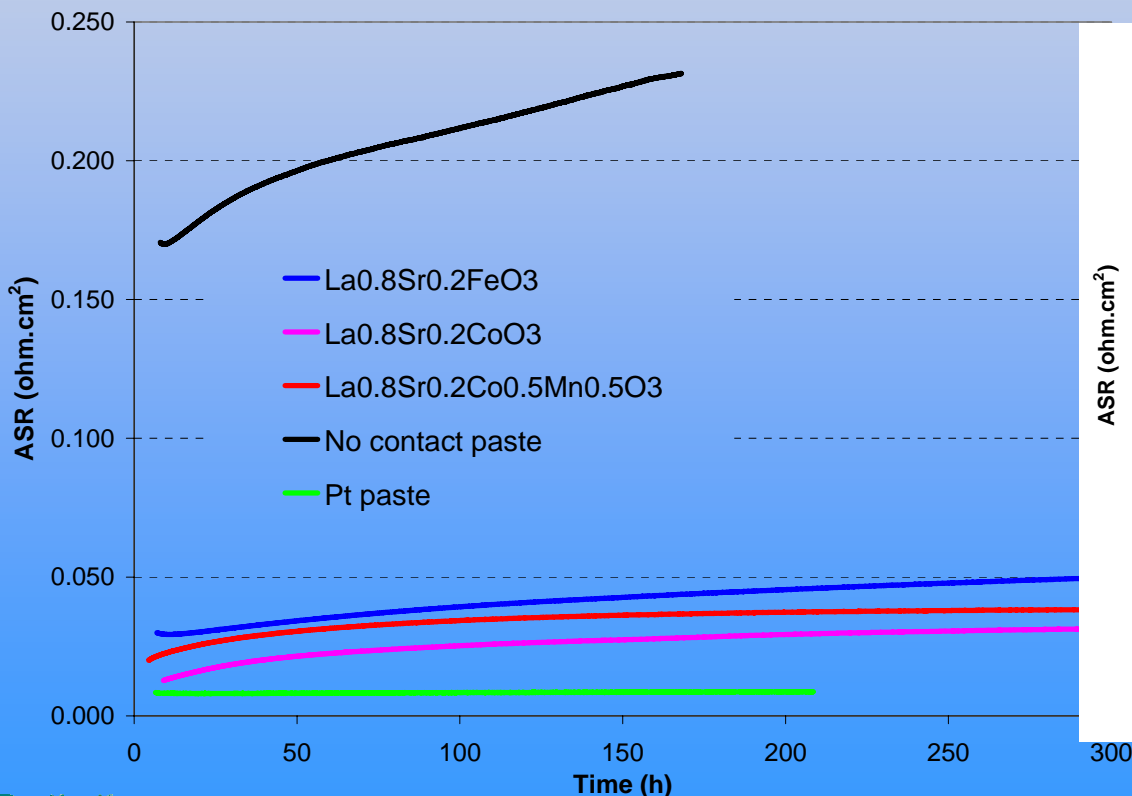
## Materials requirements

- High electrical conductivity
- Chemical compatibility
- Thermal expansion matching
- Thermochemical stability
- Low cost

# Contact Resistance

$$ASR_{contact} = \Phi \left( \begin{array}{l} \text{Scale : conductivity, growth - rate;} \\ \text{contact : area, conductivity;} \\ \text{reactions : scale | contact | electrodes} \end{array} \right)$$

- $\text{SrCrO}_4$  can be formed via both solid-solid and solid-gas reactions.
- LSM and LSCM facilitate  $(\text{Mn,Cr})_3\text{O}_4$  spinel formation.

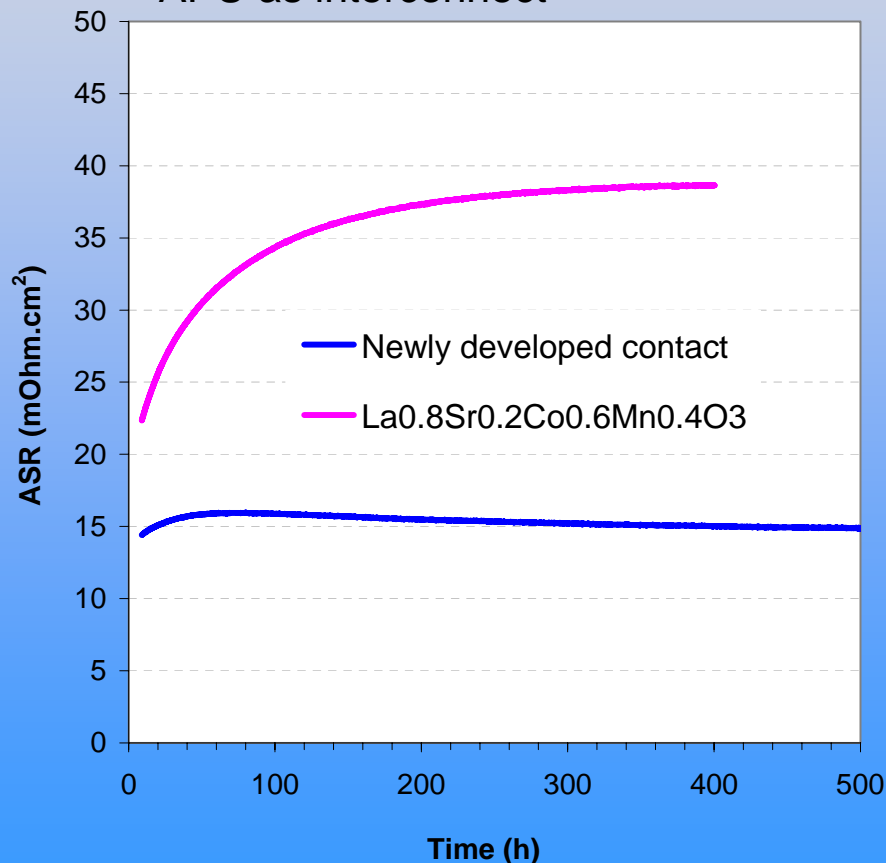


# Performance of Newly Developed Contacts

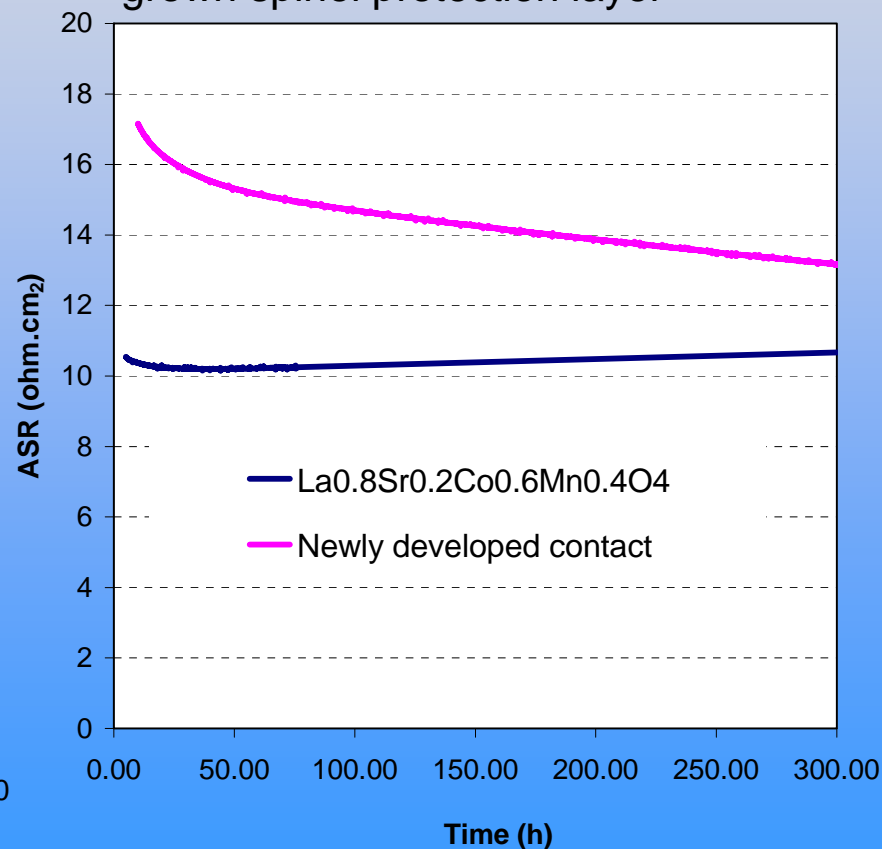
- Combination of the spinel protection layer and a newly developed contact led to a significantly minimized contact ASR.

*IRU test: LSF cathode; Temperature: 800°C*

LSF cathode and bare Crofer22 APU as interconnect



Crofer22 APU with thermally grown spinel protection layer



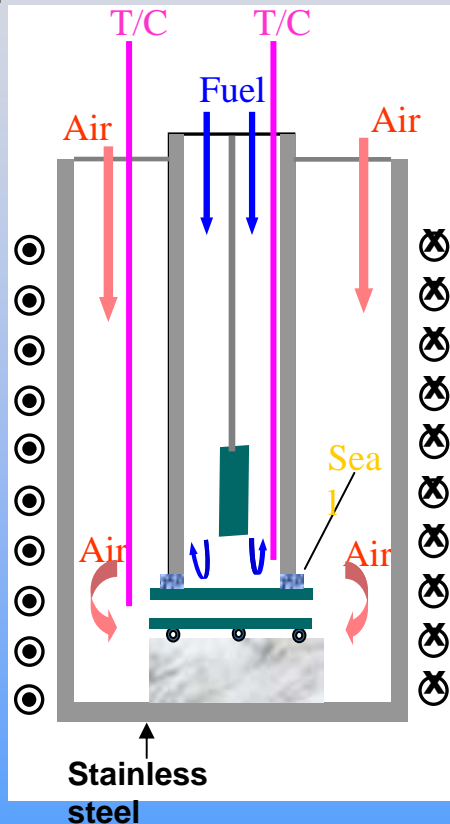
# Summary

- It is desirable to have an electrical contact layer to minimize the contact resistance between oxide cathodes and metallic interconnects.
- Screening study on perovskite contacts indicated that the contact ASR depends on scale conductivity, contact area, and conductivity of contact materials, as well as interactions between interconnects and electrical contacts.
- The combination of spinel protection layer and the newly developed contact materials demonstrated a very low contact ASR.

# Focus Areas

- Ferritic stainless steel interconnect with spinel protection layer
- Austenitic-base alloys, and laminated, composite interconnect structures
- Interactions and contact layer b/w cathode and interconnect
- Degradation of metallic interconnects under SOFC operating conditions

# Oxidation Behavior of Alloys under Interconnect Dual Exposures



- Oxidation study has been a common area of interest, but typically in a single exposure.
- Oxidation behavior under interconnect dual exposures can be very different from that in a single exposure.
- Understanding helps develop robust materials.

## Materials studied:

NiBS	{	Haynes 230-22%Cr	FeSS	{	E-brite-27%Cr
		Hastelloy S-17%Cr			Crofer22-22%Cr
		Haynes 242-9%Cr			AISI430-17%Cr
		Pure Ni, Ag, etc.			

## Variables:

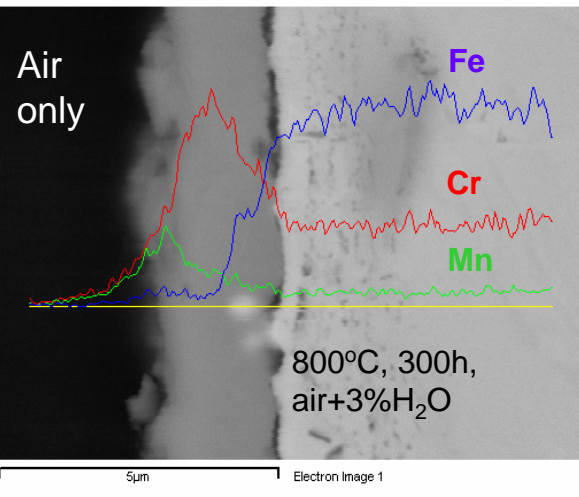
- Alloy composition
- Thermal history: isothermal vs. cycling
- Fuels: Hydrogen & Reformates

Yang, Walker, Singh, Stevenson, *Electrochem. & Solid State Lett.*, 6, B35-37 (2003).  
Yang, Walker, Singh, Stevenson, Norby, *J. Electrochem. Soc.*, 151, B669-678 (2004).  
Singh, Yang, Viswanathan, Stevenson, *J. Mater. Eng. & Perform.*, 13, 287-294 (2004).  
Yang, Xia, Singh, Stevenson, *Solid State Ionics*, in press (2005).



# Anomalous Oxidation of Alloys under Dual Exposures: A Summary

Crofer22 APU

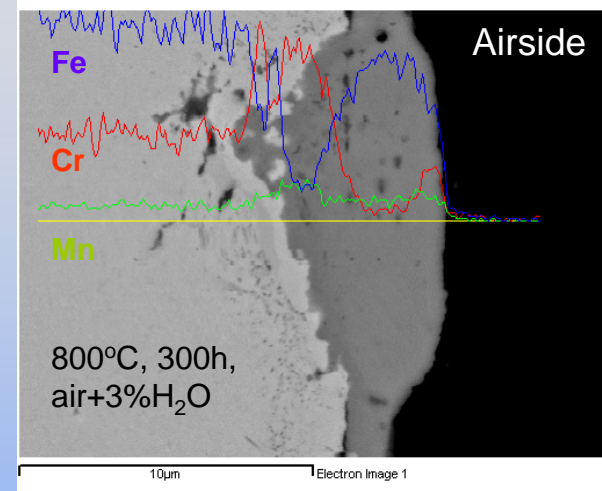


## **Ferritic stainless steels (FSS):**

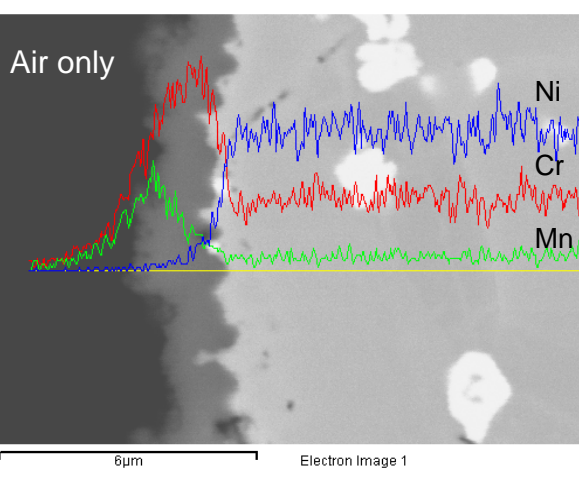
FSS demonstrate anomalous oxidation behavior under dual exposures.

Depending on alloy composition, thermal history, and surrounding environment, the anomalous oxidation can lead to a localized attack by formation of hematite nodules,

Crofer22 APU



M1 alloy

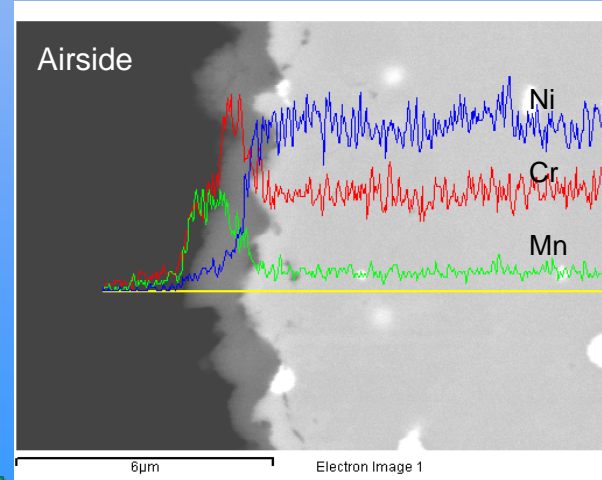


## **Ni-Cr-base alloys (NCA):**

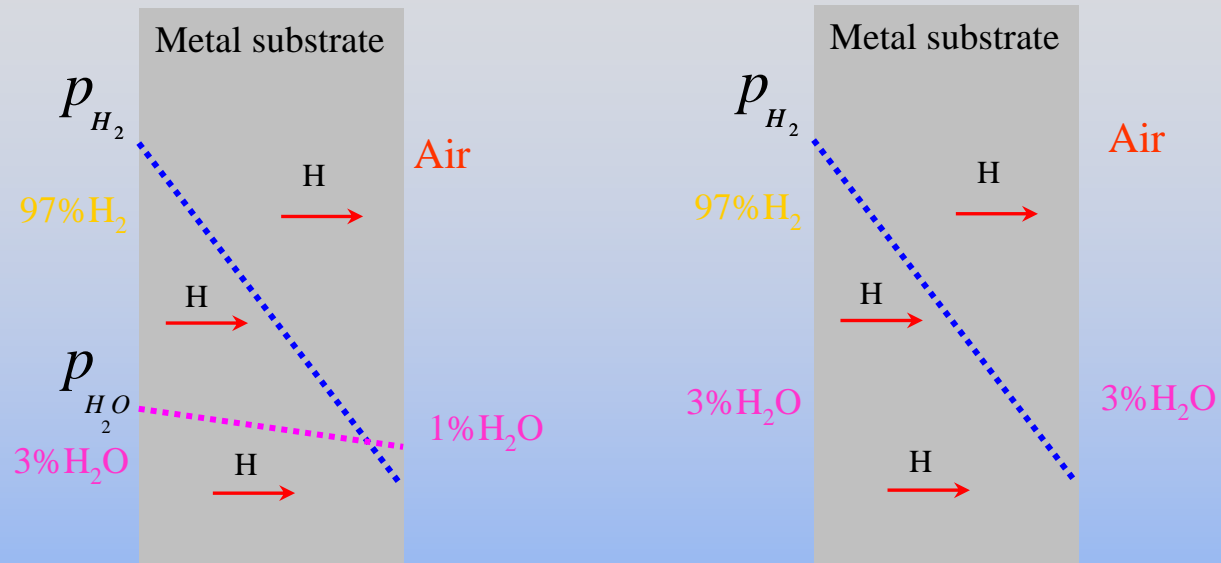
NCA also demonstrate anomalous oxidation behavior under dual exposures.

The anomalous oxidation usually leads to less defects and a better scale adherence.

M1 alloy



# H/H<sup>+</sup> Induced Anomalous Oxidation



- The anomalous oxidation of metals or alloys under dual exposures is due to the hydrogen transport from the fuel side to the airside.
- Both a hydrogen and a water vapor gradient can contribute to the hydrogen flux and affect the scale growth at the airside.
- Mechanistic understanding is an ongoing work: how the hydrogen/proton interacts with scale oxides and affects the scale composition, structure and its properties.

# Future Work:

## Surface modification of metallic interconnects

- Study spinel materials to optimize protection layers for best performance;
- Explore different approaches and search more economic ways for mass production.

## Development of electrical contact layers

- Continue to study interfacial interactions and ASR;
- Develop and optimize contact layer materials for further improved performance.

## Alloy development and optimization of clad interconnect structures

- Continue to develop and optimize bulk alloys for improved scale properties.
- Optimize laminate, composite interconnect structure and compositions.
- Study interdiffusion and predict life via modeling.

## Study of oxidation behavior and scale properties under dual exposures

- Mechanistic understanding: Interaction and transport of H/H<sup>+</sup> at the metal/oxide interface and in the oxide scale; their effects on defect structure, transport properties, scale growth.
- Oxidation behavior of alloys under the reforming gas/air dual exposures.
- Study effects of dual exposure and electrical field on scale properties.

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